Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/987,632	NISHIYAMA, SUMIO	
Examiner	Art Unit	
William C. Vaughn, Jr.	2143	

SEARCHED					
Class	Subclass	Date	Examiner		
709	216-219 224-229	7/25/2005	wcv		
709	244-246	7/25/2005	wcv		
	-	***			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

	SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR		
EAST *USPAT *USPGPUB *EPO/JPO *DERWENT *IBM_TDB	7/25/2005	wcv		
CHECK DOUBLE PATENTING *EAST, PALM, EDAN *ASSIGNEE, INVENTOR	7/25/2005	wcv		
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